

<b>Notice of References Cited</b>	Application/Control No. 10/781,485	Applicant(s)/Patent Under Reexamination CHEN, CHUAN-CHU	
	Examiner Angela M. Lie	Art Unit 2821	Page 1 of 1

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	B	US-4,047,076	09-1977	McNamara, Jr., Albert C.	315/88
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	<a href="http://www.asm-circuits.com/electronic/circuit_products/electroluminescent_lamps_manufactures_india.html">http://www.asm-circuits.com/electronic/circuit_products/electroluminescent_lamps_manufactures_india.html</a>
	V	<a href="http://wolfstone.halloweenhost.com/TechBase?cmptfr_Transformers.html">http://wolfstone.halloweenhost.com/TechBase?cmptfr_Transformers.html</a>
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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